PCN Number: 20	)19093	0000.1					PCN D	ate:	Oct. 1 2019
Title: Qualificatio	n of SC	SAT as a r	new Asse	embly	site for the A	٩DC	216DV1	50CILC	Q device family
<b>Customer Contact:</b>	PCN	Manager	Dept:		Quality Ser	vice	es		
		Jan. 1 20			Estimated Sampl Availability		-		
Change Type:									•
Assembly Site			Design			Wafer Bump Site			
Assembly Proces	s		Data Sheet				Wafer Bump Material		
Assembly Materi			Part number change						p Process
Mechanical Specification			Test Site					r Fab	
Packing/Shipping/Labeling			Test Pr	rocess			5		Materials
							Wafe	r Fab	Process
Description of Cha			PCN	Deta	nils				
Texas Instruments is pleased to announce the qualification of SCSAT as a new Assembly site for the list of devices shown below. Previous assembly site and Material differences are as follows:									
Anam Korea SCSAT									
Mount Cor	Mount Compound		SID#101375619		SID#R008-0141X			1X	
Mold Compound			SID#101317112		SID#R003-0303X		3X		
Lead finish			Matte Sn		NiPdAuAg				
ECAT			G3				G	4	
<b>Reason for Change</b>	:								
Continuity of Supply									
Anticipated impact	on Fo	rm, Fit, F	unction	, Qual	ity or Relia	bili	ty (pos	sitive	/ negative):
None									
Anticipated impact on Material Declaration									
No Impact to th	Impact to the 🛛 Material Declarations or Product Content reports are driven								
	Material Declaration from production data and will be available following the								
production release. Upon production release the revised reports can be obtained at the site link below									
		repor	ts can h	e obtai	ined at the s	site	link hel	ow	
					ined at the s quality/docs				search.tsp

Changes to product identification resulting from this PCN:						
Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	Assembly City			
Anam Korea	ANM	KOR	Bucheon-si, Gyeonggi-do			
SCSAT	STS	SGP	Singapore			

Sample product shipping label (not actual product label)



ADC16DV160CILQ/NOPB ADC16DV160CILQE/NOPB ADC16DV160CILQX/NOPB



## TI Information Selective Disclosure

Data Displayed as: Number of lots / Total sample size / Total failed					
Туре	Test Name / Condition	Duration	Qual Device: ADC16DV160CILQX/NO	QBS Package Reference: <u>LMK05805RUR-</u> <u>PG1.0/2.0/2.1</u>	QBS Package Reference: <u>TPS92682QRHMQ1 PG1.0/</u> <u>PG2.0</u>
AC	Autoclave 121C	96 Hours	1/77/0	3/231/0	3/231/0
CDM	ESD - CDM	1000 V	1/3/0	-	-
ED	Electrical Characterization.	Per Datasheet Parameters	1/30/0	-	-
HAST	Biased HAST, 110C/85%RH	264 Hours	-	2/160/0	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	3/231/0
HTOL	Life Test, 150C	300	-	-	1/77/0
HTOL	Life Test, 70C	1000 Hours	-	3/231/0	-
HTSL	High Temp Storage Bake 150C	1000 Hours	1/77/0	3/135/0	-
HTSL	High Temp Storage Bake 175C	500 Hours	-	-	3/135/0
PD	Physical Dimensions	(per mechanical drawing)	1/5/0	-	-
PB	Surface Mount Solderability	Pb Free	-	3/66/0	-
SD	Surface Mount Solderability	Pb	-	3/66/0	-
TC	Temperature Cycle, - 65/150C	500 Cycles	1/77/0	3/231/0	3/231/0
WBP	Bond Pull	Wires	1/76/0	-	-
WBS	Ball Bond Shear	Wires	1/76/0	-	-

Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

- QBS: Qual By Similarity

- Qual Device ADC16DV160CILQX/NO is qualified at LEVEL4-260C

Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240

Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status:

Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
WW PCN Team	PCN ww admin team@list.ti.com

## **IMPORTANT NOTICE AND DISCLAIMER**

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (www.ti.com/legal/termsofsale.html) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.